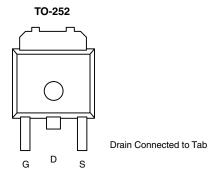


## N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω) Max.	Q <sub>g</sub> (Typ.)				
60	0.073 at V <sub>GS</sub> = 10 V	18.2	19.8			
00	0.085 at V <sub>GS</sub> = 4.5 V	13.2	19.0			



#### **FEATURES**

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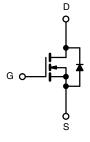
- TrenchFET<sup>®</sup> Power MOSFET
- 100 % R<sub>g</sub> and UIS Tested
- Material categorization: For definitions of compliance please see



COMPLIANT HALOGEN

#### APPLICATIONS

- DC/DC Converters
- DC/AC Inverters
- Motor Drives



N-Channel MOSFET

ABSOLUTE MAXIMUM RA	<b>TINGS</b> (T <sub>C</sub> = 25 °C, unless c	otherwise noted)		
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	60	V	
Gate-Source Voltage	V <sub>GS</sub>	± 20	v	
Continuous Drain Current	T <sub>C</sub> = 25 °C		16.9	
Continuous Drain Current	T <sub>C</sub> = 70 °C	I <sub>D</sub>	13.6	А
Pulsed Drain Current (t = 300 µs)	I <sub>DM</sub>	25		
Avalanche Current	I <sub>AS</sub>	15		
Single Avalanche Energy <sup>a</sup>	L = 0.1 mH	E <sub>AS</sub>	11.25	mJ
Maximum Power Dissipation <sup>a</sup>	T <sub>C</sub> = 25 °C	Р	41.7 <sup>b</sup>	w
	T <sub>A</sub> = 25 °C <sup>c</sup>	– P <sub>D</sub> –	2.1	~ ~ ~
Operating Junction and Storage Temper	rature Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C

THERMAL RESISTANCE RATINGS					
Parameter	Symbol	Limit	Unit		
Junction-to-Ambient (PCB Mount) <sup>c</sup>	R <sub>thJA</sub>	60	°C/W		
Junction-to-Case (Drain)	R <sub>thJC</sub>	3	0/10		

Notes:

a. Duty cycle  $\leq$  1 %.

b. See SOA curve for voltage derating.

c. When mounted on 1" square PCB (FR-4 material).

d. Base on T<sub>C</sub> = 25 °C.

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 V, I_{D} = 250 \mu A$				V	
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$	1.0		3.0	v	
Gate-Body Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 250	nA	
Zero Gate Voltage Drain Current		$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			1		
	I <sub>DSS</sub>	$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 125 ^{\circ}\text{C}$			50	μA	
		$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 150 ^{\circ}\text{C}$			250		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	20			А	
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 6.6 A		0.073		Ω	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 6 \text{ A}$		0.083			
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 6.6 A		25		S	
Dynamic <sup>b</sup>				·			
Input Capacitance	C <sub>iss</sub>			860		pF	
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V, f = 1 MHz		85			
Reverse Transfer Capacitance	C <sub>rss</sub>			40			
Total Gate Charge <sup>c</sup>	Qg			19.8	30	nC	
Gate-Source Charge <sup>c</sup>	Q <sub>gs</sub>	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 6.6 \text{ A}$		3.6			
Gate-Drain Charge <sup>c</sup>	Q <sub>gd</sub>			4.1			
Gate Resistance	R <sub>g</sub>	f = 1 MHz	0.4	2	4	Ω	
Turn-On Delay Time <sup>c</sup>	t <sub>d(on)</sub>			8	16		
Rise Time <sup>c</sup>	t <sub>r</sub>	$V_{DD}$ = 30 V, R <sub>L</sub> = 9.6 $\Omega$		11	20		
Turn-Off Delay Time <sup>c</sup>	t <sub>d(off)</sub>	$I_D \cong 5.2$ Å, $V_{GEN} = 10$ V, $R_g = 1 \Omega$		18	27		
Fall Time <sup>c</sup>	t <sub>f</sub>			5	10		
Turn-On Delay Time <sup>c</sup>	t <sub>d(on)</sub>			38	57	ns	
Rise Time <sup>c</sup>	t <sub>r</sub>	$V_{DD}$ = 30 V, $R_{L}$ = 9.6 $\Omega$		58	87	-	
Turn-Off Delay Time <sup>c</sup>	t <sub>d(off)</sub>	$I_D \cong 5.2$ Å, $V_{GEN} = 4.5$ V, $R_g = 1 \ \Omega$		18	27		
Fall Time <sup>c</sup>	t <sub>f</sub>			8	16		
Drain-Source Body Diode Ratings a	nd Characteri	stics <sup>b</sup> T <sub>C</sub> = 25 °C					
Continuous Current	۱ <sub>S</sub>				16.9	٨	
Pulsed Current	I <sub>SM</sub>				25	A	
Forward Voltage <sup>a</sup>	V <sub>SD</sub>	$I_F = 5.2 \text{ A}, V_{GS} = 0 \text{ V}$		0.8	1.5	V	
Reverse Recovery Time	t <sub>rr</sub>			34	51	ns	
Peak Reverse Recovery Current	I <sub>RM(REC)</sub>	I <sub>F</sub> = 5.2 A, dl/dt = 100 A/μs		3	5	А	
Reverse Recovery Charge	Q <sub>rr</sub>			50	75	nC	

Notes:

a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.

b. Guaranteed by design, not subject to production testing.

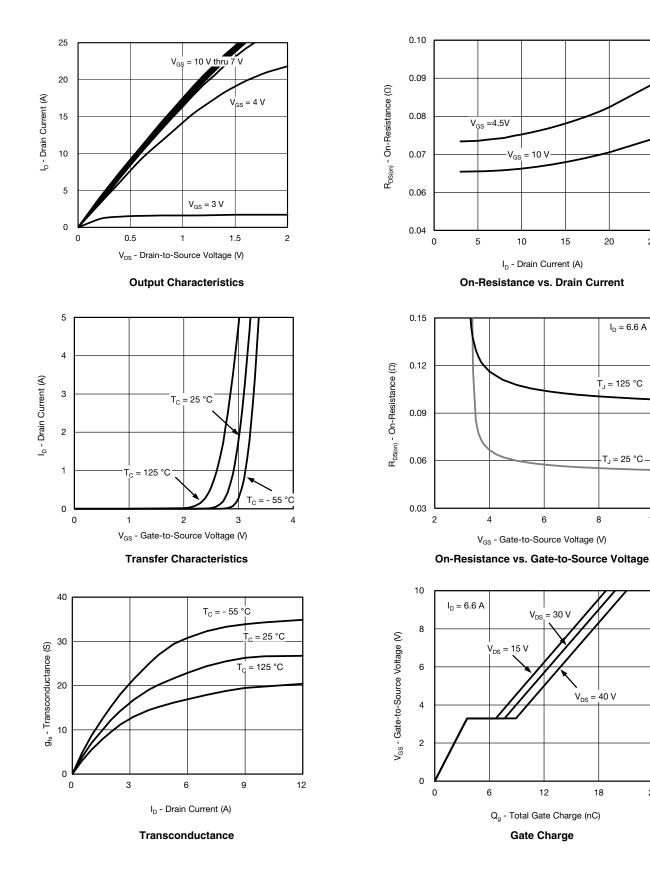
c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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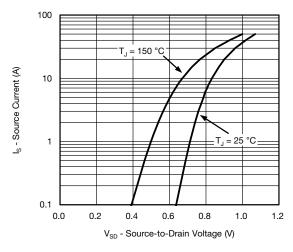


## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

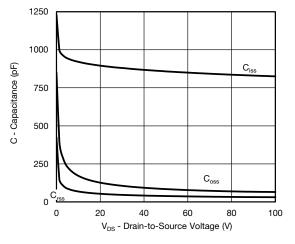




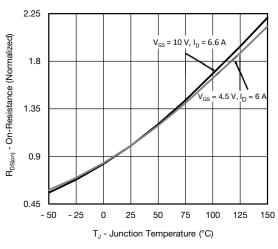
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



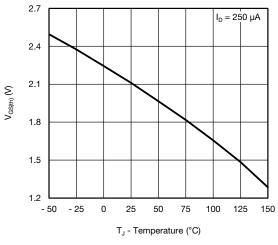
Source-Drain Diode Forward Voltage



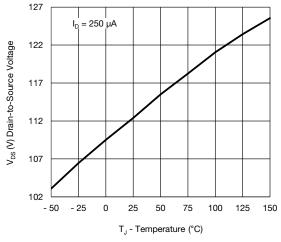




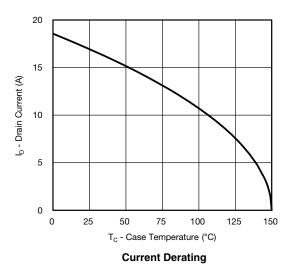
On-Resistance vs. Junction Temperature



**Threshold Voltage** 

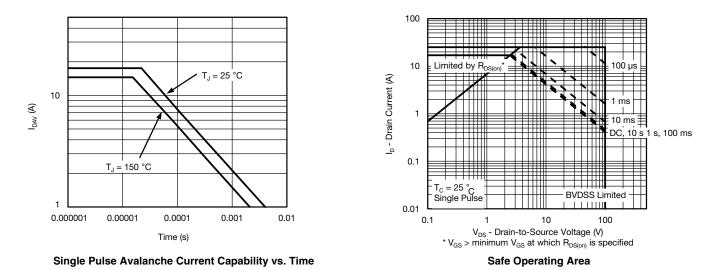


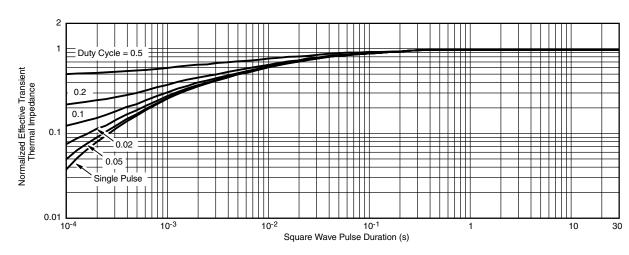
Drain Source Breakdown vs. Junction Temperature





## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

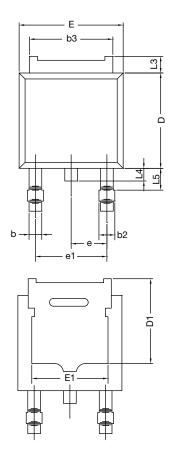


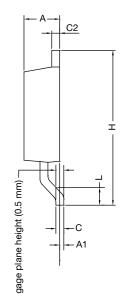


Normalized Thermal Transient Impedance, Junction-to-Case



# **TO-252AA Case Outline**





	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
А	2.18	2.38	0.086	0.094
A1	-	0.127	-	0.005
b	0.64	0.88	0.025	0.035
b2	0.76	1.14	0.030	0.045
b3	4.95	5.46	0.195	0.215
С	0.46	0.61	0.018	0.024
C2	0.46	0.89	0.018	0.035
D	5.97	6.22	0.235	0.245
D1	4.10	-	0.161	-
E	6.35	6.73	0.250	0.265
E1	4.32	-	0.170	-
Н	9.40	10.41	0.370	0.410
е	2.28 BSC		0.090 BSC	
e1	4.56	BSC	0.180	BSC
L	1.40	1.78	0.055	0.070
L3	0.89	1.27	0.035	0.050
L4	-	1.02	-	0.040
L5	1.01	1.52	0.040	0.060
ECN: T16-0236-Rev. P, 16-May-16 DWG: 5347				

#### Notes

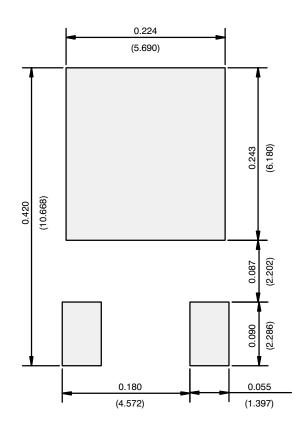
• Dimension L3 is for reference only.



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**RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)** 



Recommended Minimum Pads Dimensions in Inches/(mm)



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